

**Notice of References Cited**

Application/Control No.

10/070,055

Applicant(s)/Patent Under  
Reexamination  
HOLM ET AL.

Examiner

Roland G. Foster

Art Unit

2645

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,898,118	04-1999	Tamura, Motoichi	84/602
	B	US-6,308,086 B1	10-2001	Yoshino, Hideyuki	455/567
	C	US-6,366,791 B1	04-2002	Lin et al.	455/567
	D	US-6,400,958 B1	06-2002	Isomursu et al.	455/466
	E	US-6,418,330 B1	07-2002	Lee, Hyeon-Woo	455/567
	F	US-6,496,692 B1	12-2002	Shanahan, Michael E.	455/418
	G	US-6,501,967 B1	12-2002	Makela et al.	455/567
	H	US-6,621,903 B2	09-2003	Oda, Toshiaki	379/374.01
	I	US-6,658,455 B1	12-2003	Weinman, Jr., Joseph Bernard	709/203
	J	US-6,675,026 B2	01-2004	Yoon, Woo-Sun	455/567
	K	US-6,707,908 B1	03-2004	Nagasawa, Naokazu	379/374.01
	L	US-6,718,186 B2	04-2004	Aoki, Eriko	455/567
	M	US-2001/0024965 A1	09-2001	Hayashi, Keiichi	455/567

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0016748 A1	02-2002	Emodi et al.	705/26
	B	US-2002/0087656 A1	07-2002	Gargiulo et al.	709/217
	C	US-2002/0152091 A1	10-2002	Nagaoka et al.	705/1
	D	US-2003/0050837 A1	03-2003	Kim, Do Sik	705/14
	E	US-2003/0109251 A1	06-2003	Fujito et al.	455/414
	F	US-6,292,668 B1	09-2001	Alanara et al.	455/466
	G	US-6,370,389 B1	04-2002	Isomursu et al.	455/466
	H	US-2003/0148789 A1	08-2003	Hendra, Kendro	455/557
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	P					
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	S					
	T					

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	A	US-			
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	N					
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	P					
	Q					
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	S					
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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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